

<b>Notice of References Cited</b>	Application/Control No. 10/634,874		Applicant(s)/Patent Under Reexamination HABIBI ET AL.	
	Examiner MCDIEUNEL MARC		Art Unit 3664	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,024,280	04-2006	Parker et al.	700/245
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Crowley et al., Maintaining stereo calibration by tracking image points, 1993, IEEE, pg. 483-488
	V	Chandrashaker et al., Robotics and structural dynamics characterization of the space station remote manipulator system using photogrammetric techniques, 1994, IEEE, pg. 691-694
	W	Triboulet et al., Finding 3D polyhedral object attitude using a virtual model for industrial machining, 2001, IEEE, pg. 57-65
	X	Zhaohui et al., Image registration using a 3-D scene representation, 1998, IEEE, pg. 828-832

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	Examiner MCDIEUNEL MARC		Art Unit 3664	Page 2 of 2

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